



# DIM250PHM33-TS000

#### Replaces DS6092-3

Half Bridge IGBT Module

DS6092-4 March 2021 (LN40743)

### **FEATURES**

- 10µs Short Circuit Withstand
- High Thermal Cycling Capability
- High Current Density Enhanced DMOS SPT
- Isolated AISiC Base with AIN Substrates

### **APPLICATIONS**

- High Reliability Inverters
- Motor Controllers
- Traction Auxiliaries
- Choppers

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 1200V to 6500V and currents up to 2400A.

The DIM250PHM33-TS000 is a half bridge 3300V, soft punch through n-channel enhancement mode, insulated gate bipolar transistor (IGBT) module. The IGBT has a wide reverse bias safe operating area (RBSOA). This device is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

### **ORDERING INFORMATION**

Order As:

# DIM250PHM33-TS000

Note: When ordering, please use the complete part number

# **KEY PARAMETERS**

VCES		3300V
V <sub>CE(sat)</sub>	* (typ)	2.2V
l <sub>c</sub> `	(max)	250A
I <sub>C(PK)</sub>	(max)	500A

\* Measured at the auxiliary terminals

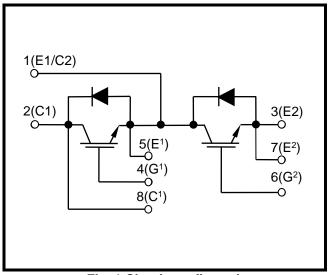
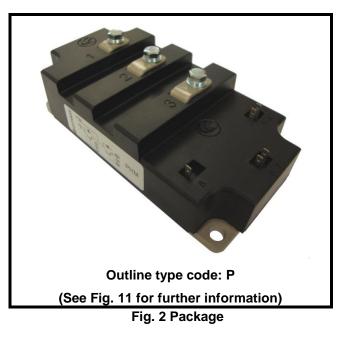


Fig. 1 Circuit configuration



### **ABSOLUTE MAXIMUM RATINGS**

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

### T<sub>case</sub> = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
Vces	Collector-emitter voltage	V <sub>GE</sub> = 0V	3300	V
V <sub>GES</sub>	Gate-emitter voltage		±20	V
lc	Continuous collector current	T <sub>case</sub> = 110°C	250	А
IC(PK)	Peak collector current	1ms, T <sub>case</sub> = 140°C	500	А
P <sub>max</sub>	Max. transistor power dissipation	$T_{case} = 25^{\circ}C, T_j = 150^{\circ}C$	2.6	kW
l²t	Diode I <sup>2</sup> t value	$V_R = 0, t_p = 10ms, T_j = 125^{\circ}C$	20	kA <sup>2</sup> s
Visol	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	6000	V
Qpd	Partial discharge – per module	IEC1287, $V_1 = 3500V$ , $V_2 = 2600V$ , 50Hz RMS	10	рС

### THERMAL AND MECHANICAL RATINGS

Internal insulation material:	AIN
Baseplate material:	AISiC
Creepage distance:	33mm
Clearance:	20mm
CTI (Comparative Tracking Index):	>600

Symbol	Parameter	Test Conditions	Min	Тур.	Мах	Units
R <sub>th(j-c)</sub>	Thermal resistance – transistor	Continuous dissipation - junction to case	-	-	48	°C/kW
R <sub>th(j-c)</sub>	Thermal resistance – Diode	Continuous dissipation - junction to case	-	-	96	°C/kW
Rth(c-h)	Thermal resistance – case to heatsink (per module)	Mounting torque 5Nm (with mounting grease)	-	-	16	°C/kW
Tj Ju	Junction temperature	Transistor	-	-	150	°C
		Diode	-	-	150	°C
T <sub>stg</sub>	Storage temperature range	-	-40	-	125	°C
		Mounting – M6	-	-	5	Nm
	Screw torque	Electrical connections – M5	-	-	4	Nm

# **ELECTRICAL CHARACTERISTICS**

### T<sub>case</sub> = 25°C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
ICES	Collector cut-off current	$V_{GE} = 0V, V_{CE} = V_{CES}$			1	mA
		$V_{GE} = 0V$ , $V_{CE} = V_{CES}$ , $T_{case} = 125^{\circ}C$			15	mA
		$V_{GE} = 0V$ , $V_{CE} = V_{CES}$ , $T_{case} = 150^{\circ}C$			25	mA
Iges	Gate leakage current	$V_{GE} = \pm 20V, V_{CE} = 0V$			1	μA
V <sub>GE(TH)</sub>	Gate threshold voltage	Ic = 20mA, V <sub>GE</sub> = V <sub>CE</sub>		5.7		V
		V <sub>GE</sub> = 15V, I <sub>C</sub> = 250A		2.2		V
V <sub>CE(sat)</sub> †	Collector-emitter saturation voltage	$V_{GE}$ = 15V, I <sub>C</sub> = 250A, T <sub>j</sub> = 125°C		2.8		V
		$V_{GE} = 15V, I_C = 250A, T_j = 150^{\circ}C$		3.0		V
lF	Diode forward current	DC		250		А
Іғм	Diode maximum forward current	t <sub>p</sub> = 1ms		500		А
	Diode forward voltage	IF = 250A		2.4		V
$V_{F}^{\dagger}$		I <sub>F</sub> = 250A, T <sub>j</sub> = 125°C		2.5		V
		I <sub>F</sub> = 250A, T <sub>j</sub> = 150°C		2.4		V
Cies	Input capacitance	$V_{CE} = 25V, V_{GE} = 0V, f = 1MHz$		45		nF
Qg	Gate charge	±15V Including external Cge		5		μC
Cres	Reverse transfer capacitance	V <sub>CE</sub> = 25V, V <sub>GE</sub> = 0V, f = 1MHz		1		nF
L <sub>M</sub>	Module inductance			40		nH
RINT	Internal transistor resistance			500		μΩ
SC <sub>Data</sub>	Short circuit current, Isc	$\begin{split} T_{j} &= 150^{\circ}C, \ V_{CC} &= 2500V \\ t_{p} &\leq 10 \mu s, \ V_{GE} &\leq 15V \\ V_{CE \ (max)} &= V_{CES} - L^{*} \ x \ dI/dt \\ IEC \ 60747-9 \end{split}$		950		A

### Note:

 $^{\dagger}\,$  Measured at the auxiliary terminals  $^{*}\,$  L is the circuit inductance +  $L_{M}$ 

# **ELECTRICAL CHARACTERISTICS**

### T<sub>case</sub> = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Мах	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>C</sub> = 250A		2700		ns
t <sub>f</sub>	Fall time	$V_{GE} = \pm 15V$		520		ns
EOFF	Turn-off energy loss	V <sub>CE</sub> = 1800V		480		mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{g(ON)} = 10\Omega$ $R_{g(OFF)} = 10\Omega$		1000		ns
tr	Rise time	$C_{GE} = 56nF$		400		ns
Eon	Turn-on energy loss	Ls ~ 150nH		320		mJ
Qrr	Diode reverse recovery charge	IF = 250A		180		μC
Irr	Diode reverse recovery current	$V_{CE} = 1800V$		160		А
Erec	Diode reverse recovery energy	dI⊧/dt = 700A/µs		165		mJ

### T<sub>case</sub> = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Мах	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>C</sub> = 250A		2750		ns
t <sub>f</sub>	Fall time	$V_{GE} = \pm 15V$		570		ns
EOFF	Turn-off energy loss	$V_{CE} = 1800V$		540		mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{g(ON)} = 10\Omega$ $R_{g(OFF)} = 10\Omega$		1020		ns
tr	Rise time	$C_{GE} = 56nF$		420		ns
Eon	Turn-on energy loss	Ls ~ 150nH		420		mJ
Qrr	Diode reverse recovery charge	IF = 250A		230		μC
Irr	Diode reverse recovery current	$V_{CE} = 1800V$		200		А
Erec	Diode reverse recovery energy	dI⊧/dt = 700A/µs		280		mJ

### T<sub>case</sub> = 150°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Мах	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>C</sub> = 250A		2800		ns
t <sub>f</sub>	Fall time	$V_{GE} = \pm 15V$		550		ns
EOFF	Turn-off energy loss	$V_{CE} = 1800V$		580		mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{g(ON)} = 10\Omega$ $R_{g(OFF)} = 10\Omega$		1030		ns
tr	Rise time	$C_{GE} = 56nF$		430		ns
Eon	Turn-on energy loss	Ls ~ 150nH		460		mJ
Qrr	Diode reverse recovery charge	IF = 250A		270		μC
Irr	Diode reverse recovery current	$V_{CE} = 1800V$		200		Α
Erec	Diode reverse recovery energy	dI⊧/dt = 700A/µs		330		mJ

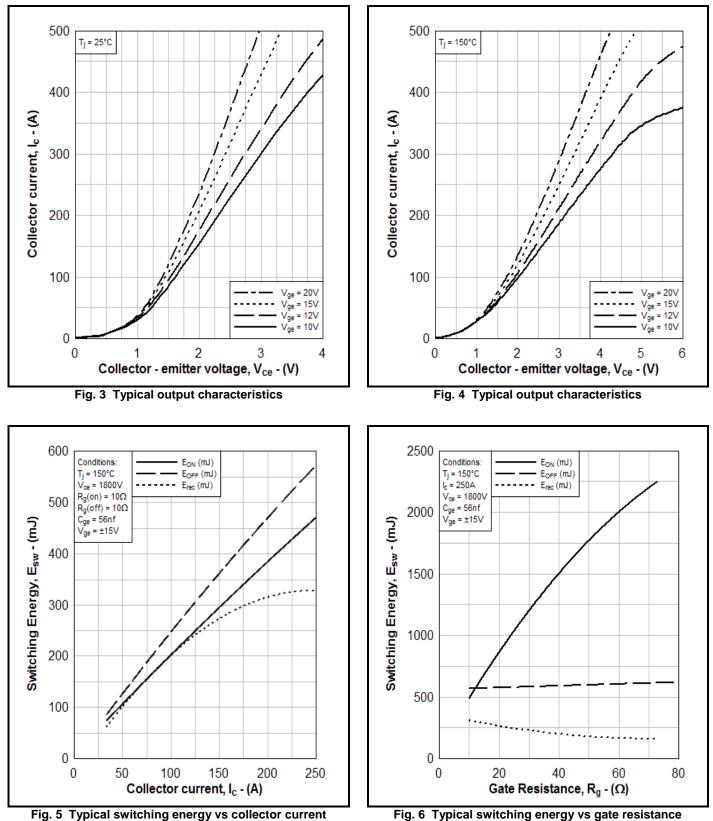


Fig. 6 Typical switching energy vs gate resistance

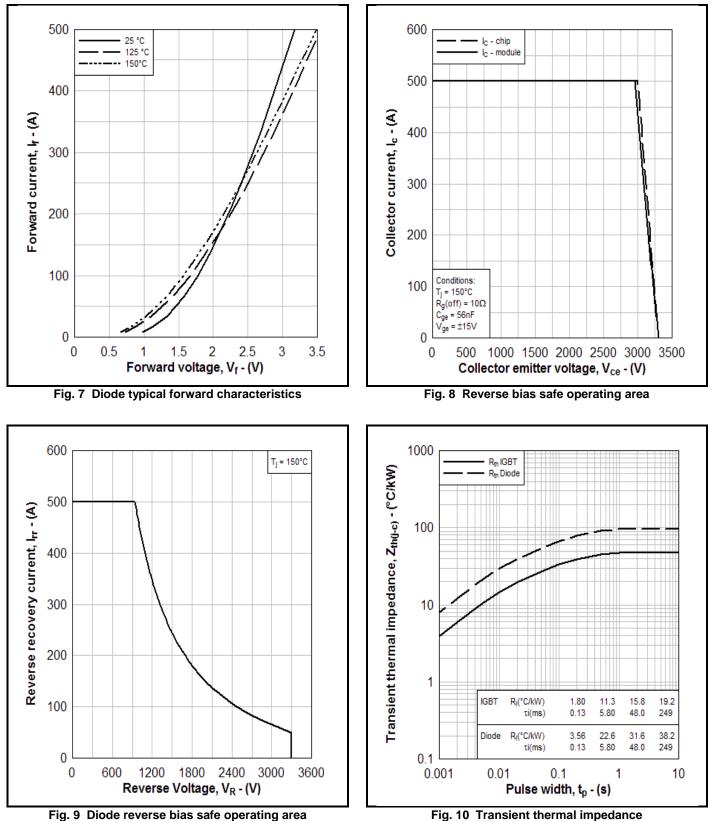
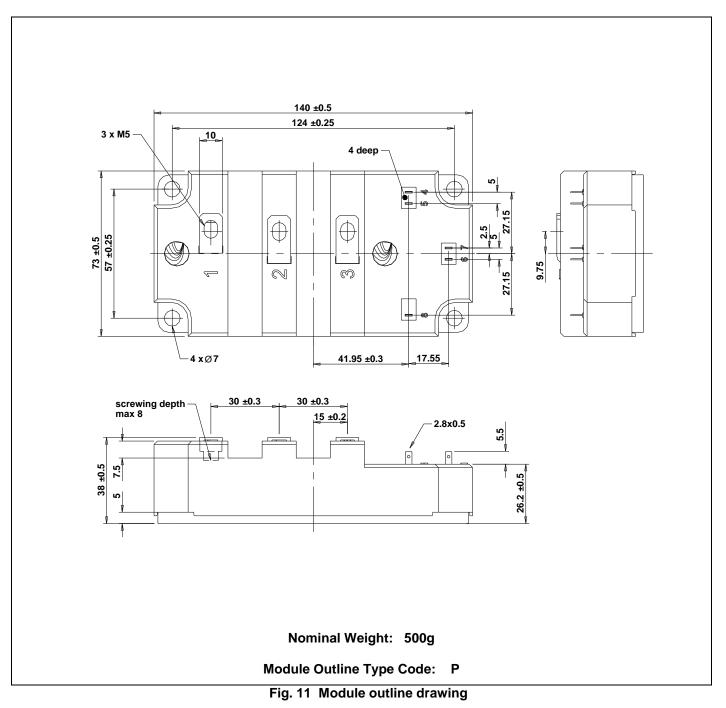


Fig. 10 Transient thermal impedance

### PACKAGE DETAILS

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise. **DO NOT SCALE.** 



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